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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Complete if Known						
Application Number 10/785,248						
Filing Date	02/24/2004					
First Named Inventor	Choi et al.					
Group Art Unit	1756					
Examiner Name	Young, Christopher G.					
Attorney Docket Number	PA132-08D09					

U.S. PATENT DOCUMENTS										
Examiner	Cite	U.S. Patent Docu		Name of Patentee or Applicant	Date of Publication of	Pages, Columns, Lines,				
Initials*	No.1	Number	Kind Code ^z (# known)	of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear				
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λ /	A2	4,600,309		Fay	07-15-1986					
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Examiner Signature	Ή.	1/2.0			Date Considered	1/2005				

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Substitute fo	or form 1449A/PTO			Complete if Known		
				Application Number	10/785,248	
INFOF	RMATION D	ISC	LOSURE	Filing Date	02/24/2004	
STAT	EMENT BY	APF	PLICANT	First Named Inventor	Choi et al.	
	• .			Group Art Unit	1756	
(use as many sheets as necessary)				Examiner Name	Young, Christopher G.	
Sheet	2	of	8	Attorney Docket Number	PA132-08D09	

				U.S. PATENT DOCUMEN	TS	
Examiner Initials*	Cite No.1	U.S. Patent Do	cument Kind Code ² (il known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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	A37	5,417,802		Obeng	05-23-1995	
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				Application Number	10/785,248	
INFOR	MATION	DISCL	OSURE	Filing Date	02/24/2004	
STATE	MENT E	SY APPL	LICANT	First Named Inventor	Choi et al.	
•				Group Art Unit	1756	
(use as many sheets as necessary)				Examiner Name	Young, Christopher G.	
Sheet	3	of	8	Attorney Docket Number	PA132-08D09	

		U.S. Patent Doc		I	Date of Publication of	Pages, Columns, Lines,
Examiner Initials*	Cite No.1	Number	Kind Code ² (# known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear
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h	A100	2003/0129542	A1	Shih et al.	07-10-2003	
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xamine Signature		1 /h	yn,		Date Considered	1/2015

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Substitute for form 1449A/PTO				Complete if Known		
				Application Number	10/785,248	
- INFC	RMATION D	ISC	LOSURE	Filing Date	02/24/2004	
STA	TEMENT BY	AP	PLICANT	First Named Inventor	Choi et al.	
				Group Art Unit	1756	
	(use as many sheets	as ne	cessary)	Examiner Name	Young, Christopher G.	
Sheet	4	of	8	Attorney Docket Number	PA132-08D09	

				U.S. PATENT DOCUMENT	<u> </u>	
Examiner Initials*	Cite No.1	U.S. Patent Doc	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Substitute	for form 1449A/PTC)		Complete if Known		
				Application Number	10/785,248	
INFO	RMATION D	DISCL	OSURE	Filing Date	02/24/2004	
STAT	TEMENT BY	'APP	LICANT	First Named Inventor	Choi et al.	
				Group Art Unit	1756	
(use as many sheets as necessary)				Examiner Name	Young, Christopher G.	
Sheet	5	of	8	Attorney Docket Number	PA132-08D09	

				FOREIGN	PATENT DOCUMENTS			
	Τ		Foreign Patent Docum	ent		Date of Publication of	Pages, Columns, Lines,	Т
Examiner Initials*	Cite No.1	Office ³	Number ⁴	Kind Code ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	Τ°
m	A115	JP	63-138730	[Koji	12-01-1986		T
4	A116	JP	55-88332		Masahiro	12-26-1978		
	A117	JP	57-7931		Tadao et al.	06-18-180	-	\top
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-▼	A120	wo	00/21689	Ì	Chou et al.	04-20-2000		+
my	A121	wo	01/47003	A2	Steiner et al.	06-28-2001		
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Substitu	te for form 1449B	3/PTO		Complete if Known		
	•			Application Number	10/785,248	
INFO	PRMATION	N DISCI	LOSURE	Filing Date	02/24/2004	
STA	TEMENT	BY APP	LICANT	First Named Inventor	Choi et al.	
•				Group Art Unit	1756	
	(use as many sh	eets as nece	ssary)	Examiner Name	Young, Christopher G.	
Sheet	6	of	8	Attorney Docket Number	PA132-08D09	

OTHER PRIO	R ART - N	NON PATENT LITERATURE DOCUMENTS						
Examiner Cite No.		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
Cong	A122	Abstract of Japanese Patent 63-138730						
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				Application Number	10/785,248	
INFO	ORMATION	I DISC	LOSURE	Filing Date	02/24/2004	
STA	TEMENT E	SY APP	PLICANT	First Named Inventor	Choi et al.	
				Group Art Unit	1756	
	(use as many she	eets as nec	essary) -	Examiner Name	Young, Christopher G.	
Sheet	7	of	8	Attorney Docket Number	PA132-08D09	

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Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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·	A137	Papirer et al., "The Graftijng of Perfluorinated Silanes onto the Surface of Silica: Characterization by Inverse Gas Chromatography," August 1993, pp238-242, vol. 159, Issue 1.	
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·	A140	Abstract of Hirai et al., "Mold Surface Treatment for Imprint Lithography," August 2001, pp 457-462, vol 14, No. 3.	
	A141	Sung et al., "Micro/nano-tribological Characteristics of Self-Assembled Monoloayer and its Application in Nano-Structure Fabrication," July 2003, pp. 808-818, vol. 255, no. 7.	
7	A142	Abstract of Sung et al., "Micro/nano-tribological Characteristics of Self-Assembled Monoloayer and its Application in Nano-Structure Fabrication," July 2003, pp. 808-818, vol. 255, no. 7.	
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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number. Complete if Known Substitute for form 1449B/PTO **Application Number** 10/785,248 INFORMATION DISCLOSURE Filing Date 02/24/2004 STATEMENT BY APPLICANT **First Named Inventor** Choi et al. **Group Art Unit** 1756 (use as many sheets as necessary) Young, Christopher G. **Examiner Name** 8 **Sheet** of PA132-08D09 Attorney Docket Number

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS							
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, senal, symposlum, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²				
Cmy	A144	Abstract of Roos et al., "Nanoimprint Lithography with a Commerical 4 Inch Bond System for Hot Embossing," October 2001, pp. 427-435, vol. 4343.					
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